# onsemi

### Silicon Carbide (SiC) MOSFET – 80 mohm, 1200 V, M1, D2PAK-7L

## NTBG080N120SC1

#### Features

- Typ.  $R_{DS(on)} = 80 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ.  $Q_{G(tot)} = 56 \text{ nC}$ )
- Low Effective Output Capacitance (Typ. Coss = 79 pF)
- 100% Avalanche Tested
- $T_J = 175^{\circ}C$
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb–Free 2LI (on second level interconnection)

#### **Typical Applications**

- UPS
- DC-DC Converter
- Boost Inverter

#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

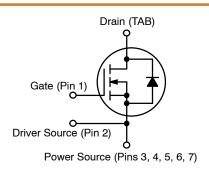
Para	Symbol	Value	Unit		
Drain-to-Source Volta	V <sub>DSS</sub>	1200	V		
Gate-to-Source Volta	ge		V <sub>GS</sub>	-15/+25	V
Recommended Operate Values of Gate-Source		T <sub>C</sub> < 175°C	V <sub>GSop</sub>	-5/+20	V
Continuous Drain Current (Note 1)	,		Ι <sub>D</sub>	30	A
Power Dissipation (Note 1)			P <sub>D</sub>	179	W
Continuous Drain Current (Note 1)	Steady State	T <sub>C</sub> = 100°C	۱ <sub>D</sub>	21	A
Power Dissipation (Note 1)			P <sub>D</sub>	89	W
Pulsed Drain Current (	Pulsed Drain Current (Note 2) $T_C = 25^{\circ}C$				А
Operating Junction and Range	T <sub>J</sub> , T <sub>stg</sub>	−55 to +175	°C		
Source Current (Body	۱ <sub>S</sub>	18	А		
Single Pulse Drain-to-Source Avalanche Energy ( $I_L$ = 18.5 $A_{pk}$ , L = 1 mH) (Note 3)			E <sub>AS</sub>	171	mJ
Maximum Lead Tempe 1/8" from Case for 10 S		oldering,	ΤL	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

 The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

Repetitive rating, limited by max junction temperature.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
1200 V	110 m $\Omega$ @ 20 V	30 A



#### N-CHANNEL MOSFET



D2PAK-7L CASE 418BJ

#### MARKING DIAGRAM



A = Assembly Location

Y = Year

WW = Work Week

ZZ = Lot Traceability NTBG080120SC1 = Specific Device Code

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTBG080N120SC1	D2PAK-7L	800 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, <u>BRD8011/D</u>.

3.  $E_{AS}$  of 171 mJ is based on starting  $T_J$  = 25°C; L = 1 mH,  $I_{AS}$  = 18.5 A,  $V_{DD}$  = 120 V,  $V_{GS}$  = 18 V.

#### Table 1. THERMAL CHARACTERISTICS

Parameter	Symbol	Мах	Unit
Thermal Resistance Junction-to-Case (Note 1)	$R_{ extsf{ heta}JC}$	0.84	°C/W
Thermal Resistance Junction-to-Ambient (Note 1)	$R_{ hetaJA}$	40	°C/W

#### Table 2. ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = $25^{\circ}$ C unless otherwise stated)

Parameter	Symbol	Test C	Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	-			-	-	-	-
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA		1200			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = 1 mA, refer	to 25°C		0.5		V/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$			100	μA
		V <sub>DS</sub> = 1200 V	T <sub>J</sub> = 175°C			1	mA
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = +25/-15 V	V, V <sub>DS</sub> = 0 V			±1	μΑ
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	5 mA	1.8	3	4.3	V
Recommended Gate Voltage	V <sub>GOP</sub>			-5		+20	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 20 V, I <sub>D</sub> =	= 20 A, T <sub>J</sub> = 25°C		80	110	mΩ
		V <sub>GS</sub> = 20 V, I <sub>D</sub> =	= 20 A, T <sub>J</sub> = 150°C		121		mΩ
Forward Transconductance	<b>9</b> FS	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 20 A			11		S
CHARGES, CAPACITANCES & GATE RES	SISTANCE						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 800 V			1154		pF
Output Capacitance	C <sub>OSS</sub>				79		
Reverse Transfer Capacitance	C <sub>RSS</sub>				7.9		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -5/20 \text{ V}, \text{ V}_{DS} = 600 \text{ V},$ $I_D = 20 \text{ A}$			56		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				10		
Gate-to-Source Charge	Q <sub>GS</sub>				18		1
Gate-to-Drain Charge	Q <sub>GD</sub>				11		
Gate-Resistance	R <sub>G</sub>	f = 1 MHz			1.2		Ω
SWITCHING CHARACTERISTICS							1
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = -5/20 V, V$			12	22	ns
Rise Time	t <sub>r</sub>	I <sub>D</sub> = 20 A, R <sub>G</sub> = Inductive Load	4.7 Ω,		12	22	
Turn-Off Delay Time	t <sub>d(OFF)</sub>				21	34	
Fall Time	t <sub>f</sub>				9	18	
Turn–On Switching Loss	E <sub>ON</sub>				135		μJ
Turn–Off Switching Loss	E <sub>OFF</sub>				46		
Total Switching Loss	E <sub>TOT</sub>	1			181		
DRAIN-SOURCE DIODE CHARACTERIS				1	1	1	1
Continuous Drain-Source Diode Forward	I <sub>SD</sub>	V <sub>GS</sub> = -5 V, T <sub>J</sub> =	= 25°C			18	Α

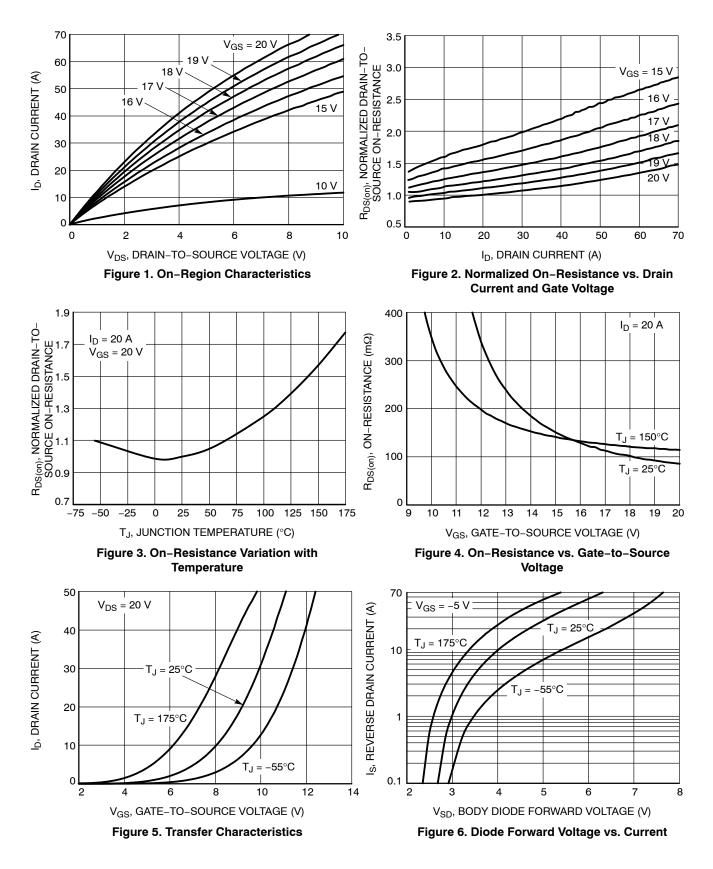
Continuous Drain-Source Diode Forward Current	ISD	$v_{GS} = -5 v, 1j = 25^{\circ}C$		18	A
Pulsed Drain-Source Diode Forward Current (Note 2)	I <sub>SDM</sub>	V <sub>GS</sub> = -5 V, T <sub>J</sub> = 25°C		110	A
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS}$ = –5 V, $I_{SD}$ = 10 A, $T_J$ = 25°C	3.9		V

#### Table 2. ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = $25^{\circ}$ C unless otherwise stated) (continued)

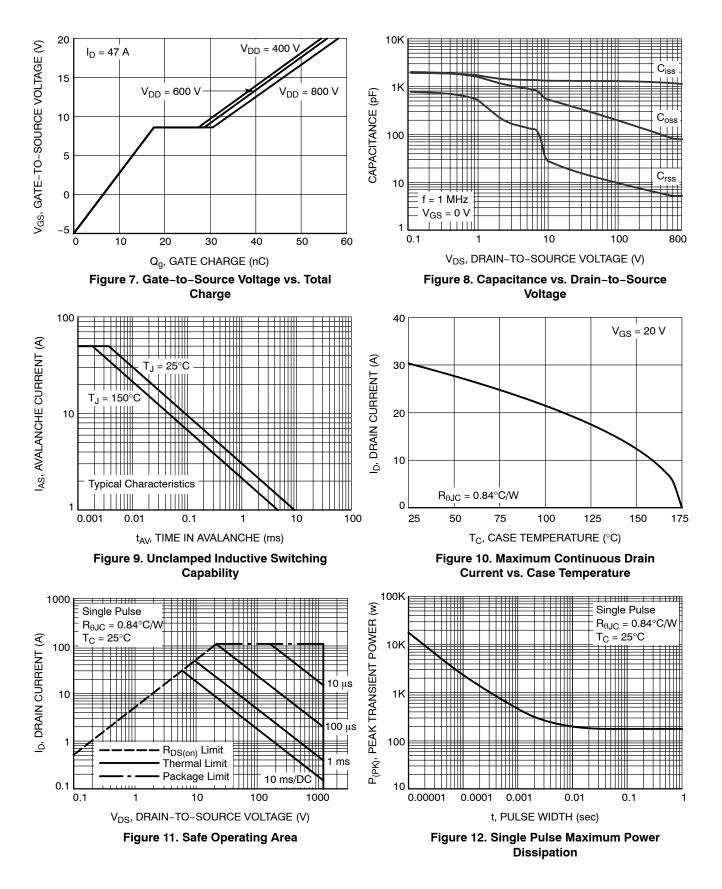
Parameter	Symbol	Test Condition	Min	Тур	Max	Unit		
DRAIN-SOURCE DIODE CHARACTERISTICS								
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = -5/20$ V, $I_{SD} = 20$ A, $dI_S/dt = 1000$ A/µs		16.2		ns		
Reverse Recovery Charge	Q <sub>RR</sub>			61.6		nC		
Reverse Recovery Energy	E <sub>REC</sub>			4.1		μJ		
Peak Reverse Recovery Current	I <sub>RRM</sub>			7.6		А		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL CHARACTERISTICS**



#### TYPICAL CHARACTERISTICS (continued)



#### TYPICAL CHARACTERISTICS (continued)

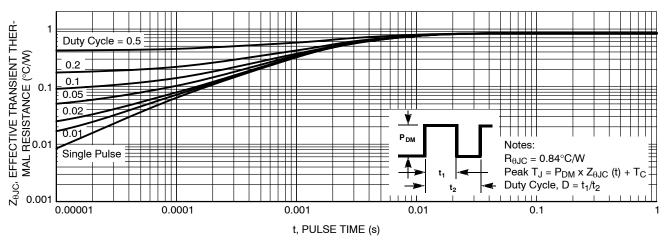
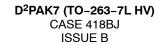


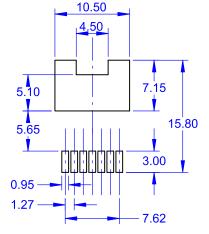
Figure 13. Junction-to-Case Transient Thermal Response Curve

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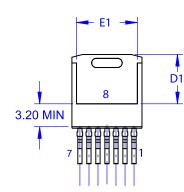




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LAND PATTERN RECOMMENDATION



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GENERIC **MARKING DIAGRAM\*** 

XXXXXXXXX AYWWG
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XXXX = Specific Device Code А = Assembly Location Y = Year

- WW = Work Week
- G = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

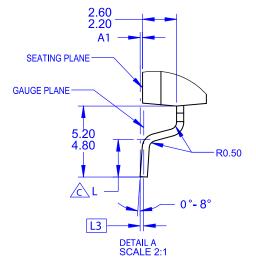
B	A
c2 —	
•	
H	
	A

NOTES:

A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.

C OUT OF JEDEC STANDARD VALUE. D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009. E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.

DIM	MILLIMETERS				
	MIN	NOM	MAX		
Α	4.30	4.50	4.70		
A1	0.00	0.10	0.20		
b2	0.60	0.70	0.80		
b	0.51	0.60	0.70		
С	0.40	0.50	0.60		
c2	1.20	1.30	1.40		
D	9.00	9.20	9.40		
D1	6.15	6.80	7.15		
E	9.70	9.90	10.20		
E1	7.15	7.65	8.15		
е	~	1.27	~		
Н	15.10	15.40	15.70		
L	2.44	2.64	2.84		
L1	1.00	1.20	1.40		
L3	~	0.25	~		
aaa	~	~	0.25		



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